Search Notes

Application/Control No.		Applicant(s)/Patent under Reexamination		
10/767,73	25	OGAWA, HIDE	нко	
Examiner	,	Art Unit		
Thomas	D. Lee	2625		

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Class	Subclass	Date	Examiner
358	1.15, 402, 440	12/8/2005	TDŁ
379	100.01	12/8/2005	TDL
379	100.08	12/8/2005	TDL
379	100.13	12/8/2005	TDL
379	100.17	12/8/2005	TDL
updated		5/23/2006	TDL

INT	NTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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